

<b>Notice of References Cited</b>	Application/Control No. 10/625,234	Applicant(s)/Patent Under Reexamination TANI, KENTARO	
	Examiner A. Sefer	Art Unit 2826	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,888,844	03-1999	Bestwick et al.	438/46
	B	US-6,387,721	05-2002	Hashimoto et al.	438/46
	C	US-2002/0187577	12-2002	Sakata et al.	438/39
	D	US-5,400,740	03-1995	Goto et al.	117/91
	E	US-6,249,140	06-2001	Shigihara, Kimio	324/767
	F	US-2003/0021320	01-2003	Kan, Yasuo	372/46
	G	US-2003/0128730	07-2003	Ohkubo, Nobuhiro	372/46
	H	US-5,636,237	06-1997	Terakado et al.	372/46
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1104058	05-2001	European	Arakawa et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.